

Notice of References Cited	Application/Control No. 10/752,675	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2004/0236939 A1	11-2004	Watanabe et al.	713/150
	C	US-2005/0117524 A1	06-2005	Lee et al.	370/254
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	M	US-			

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NON-PATENT DOCUMENTS

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